

110V, 173A, 3.8mΩ N-channel Power SGT MOSFET

JMSH1103TC

Features

- $\bullet \;\;$ Excellent $R_{DS(ON)}$ and Low Gate Charge
- 100% UIS TESTED
- 100% ΔVds TESTED
- Halogen-free; RoHS-compliant
- Pb-free plating

Applications

- Load Switch
- PWM Application
- Power Management

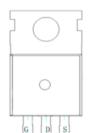
Product Summary

Parameters	Value	Unit
V_{DSS}	110	V
$V_{GS(th)_Typ}$	3.0	V
$I_D(@V_{GS}=10V)$	173	Α
$R_{DS(ON)_Typ}(@V_{GS}=10V$	3.8	mΩ

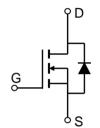








Pin Assignment



Schematic Diagram

Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSH1103TC	SH1103T	N/A	Tape&Reel	TO-220-3L	50	5000

Absolute Maximum Ratings (@ T_C = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit
V_{DS}	Drain-to-Source Voltage		110	V
V_{GS}	Gate-to-Source Voltage		±20	V
	Continuous Drain Current	$T_C = 25^{\circ}C$	173	Λ
I _D	Continuous Diam Current	$T_C = 100$ °C	122	- A
I_{DM}	Pulsed Drain Current (1)		Refer to Fig.4	Α
E _{AS}	Single Pulsed Avalanche Energ	y ⁽²⁾	820	mJ
P _D		$T_C = 25^{\circ}C$	325	W
		$T_C = 100$ °C	130	
T_{J}, T_{STG}	Junction & Storage Temperature F	Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾ 70		°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.4	C/VV



Electrical Characteristics (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	racteristics					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	110	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 88V, V_{GS} = 0V$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.1	3.0	3.9	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 10V, I_D = 20A$	-	3.8	5.0	mΩ
Dynami	ic Characteristics					
R_{g}	Gate Resistance	f = 1MHz	-	2.2	-	Ω
C _{iss}	Input Capacitance	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	-	5718	-	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 55V,$ f = 1MHz	-	816	-	pF
C_{rss}	Reverse Transfer Capacitance		-	27	-	pF
Q_g	Total Gate Charge		-	86	-	nC
Q _{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 55V, I_D = 20A$	-	30	-	nC
Q_{gd}	Gate Drain("Miller") Charge	VDS = 33 V, ID = 20/1	-	19	-	nC
Switchi	ng Characteristics	-		_	ı	ı
$t_{d(on)}$	Turn-On DelayTime		-	25	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 55V$	-	41	-	ns
$t_{d(off)}$	Turn-Off DelayTime	I_{D} = 20A, R_{GEN} = 6.2 Ω	-	67	-	ns
t _f	Turn-Off Fall Time		-	42	-	ns
Body D	iode Characteristics					
I_S	Maximum Continuous Body Diode Forward	Current	-	-	173	Α
I _{SM}	Maximum Pulsed Body Diode Forward Curr	ent	-	-	691	А
V_{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	I _F = 20A, di/dt = 100A/us	-	82	-	ns
Qrr	Body Diode Reverse Recovery Charge	I _F = 20A, ui/ul = 100A/us	-	223	-	nC

Notes:

^{1.} Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

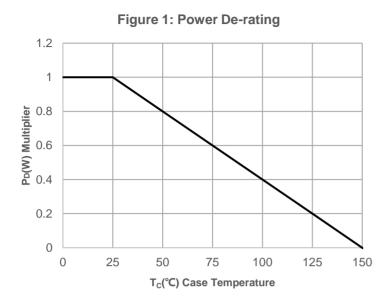
 $^{2.\;}E_{AS}\;condition:\;Starting\;T_J=25C,\;V_{DD}=55V,\;V_G=10V,\;R_G=25ohm,\;L=3mH,\;I_{AS}=23.38A,\;V_{DD}=0V\;during\;time\;in\;avalanche.$

^{3.} $R_{\theta JA}$ is measured with the device mounted on a 1inch² pad of 2oz copper FR4 PCB.

^{4.} Pulse Test: Pulse Width≤300μs, Duty Cycle≤0.5%.



Typical Performance Characteristics



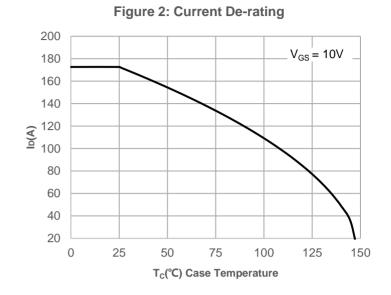
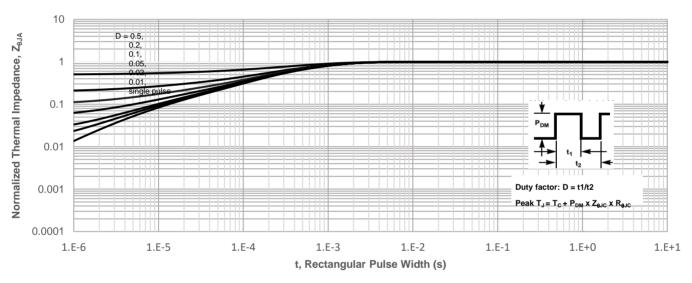
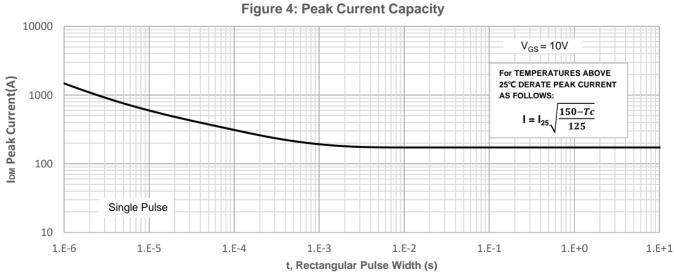


Figure 3: Normalized Maximum Transient Thermal Impedance







Typical Performance Characteristics

Figure 5: Output Characteristics

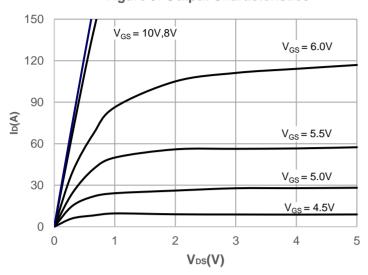


Figure 6: Typical Transfer Characteristics

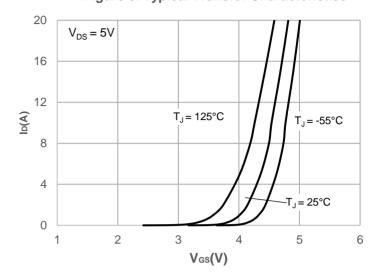


Figure 7: On-resistance vs. Drain Current

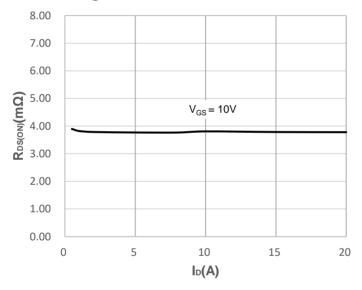


Figure 8: Body Diode Characteristics

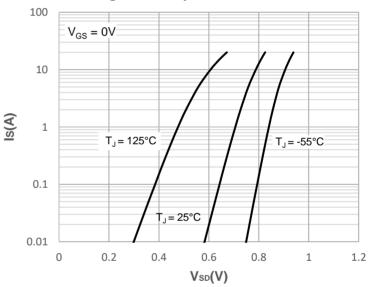


Figure 9: Gate Charge Characteristics

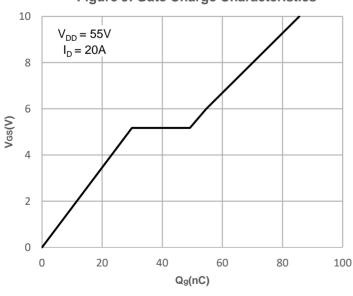
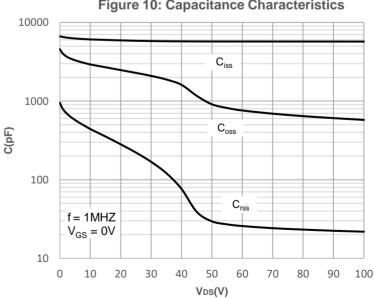


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

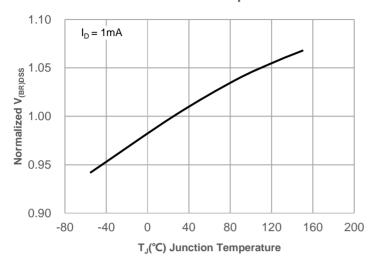


Figure 13: Normalized Threshold Voltage vs. Junction Temperature

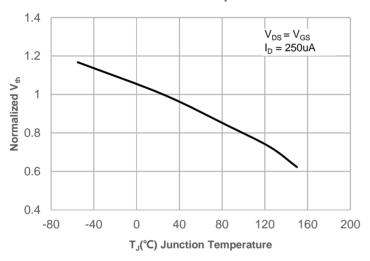


Figure 15: Maximum Safe Operating Area

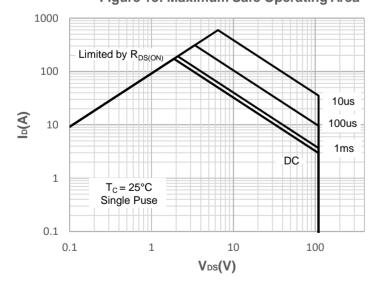
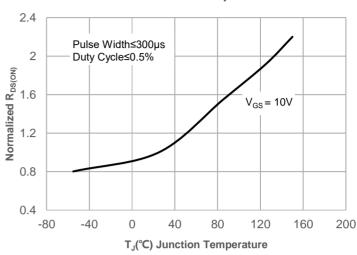
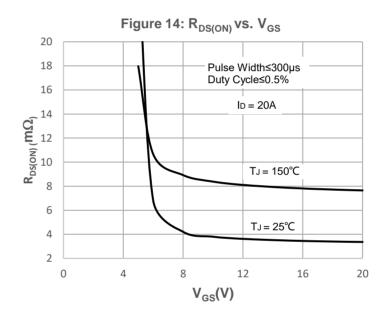


Figure 12: Normalized on Resistance vs. Junction Temperature







Test Circuit

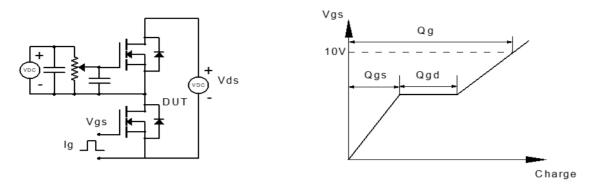


Figure 1: Gate Charge Test Circuit & Waveform

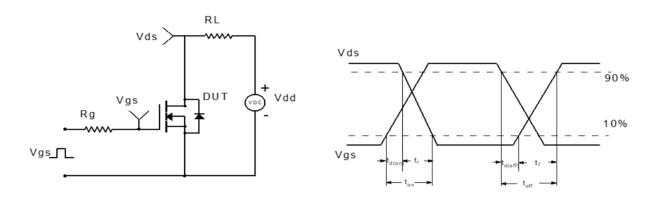


Figure 2: Resistive Switching Test Circuit & Waveform

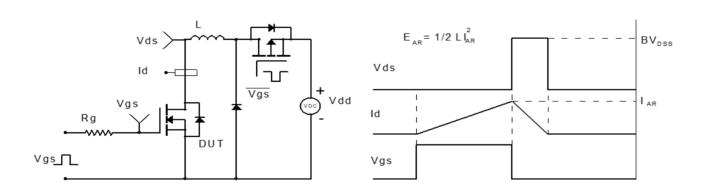


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

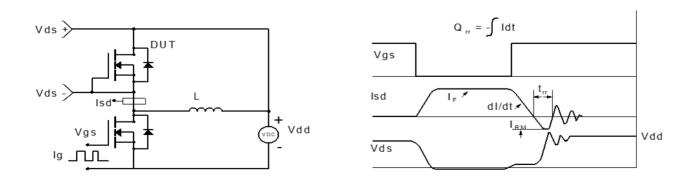
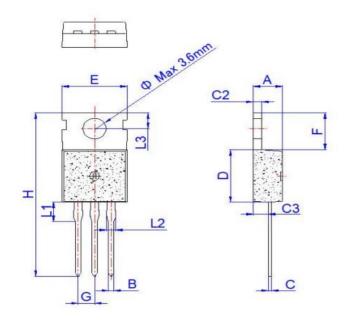


Figure 4: Diode Recovery Test Circuit & Waveform



Package Mechanical Data(TO-220-3L)



Ref.			Dime	ensions		
	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	4.40		4.60	0.173		0.181
В	0.70		0.90	0.028		0.035
C	0.45		0.60	0.018		0.024
C2	1.23		1.32	0.048		0.052
C3	2.20		2.60	0.087		0.102
D	8.90		9.90	0.350		0.390
E	9.90		10.3	0.390		0.406
F	6.30		6.90	0.248		0.272
G		2.54			0.1	
Н	28.0		29.8	1.102		1.173
L1		3.39			0.133	
L2	1.14		1.70	0.045		0.067
L3	2.65		2.95	0.104		0.116
Ф		3.6			0.142	

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